

Search Notes

Application/Control No.

10/033,088

Examiner

Erin M. File

Applicant(s)/Patent under
Reexamination

YUICHIRO TAKAMIZAWA

Art Unit

2634

SEARCHED

Class	Subclass	Date	Examiner
358	1.15	3/2/2005	EMF
375	240	3/2/2005	EMF
382	239	3/2/2005	EMF
704	201	3/2/2005	EMF
704	500	3/2/2005	EMF

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	240	3/2/2005	EMF
704	500	3/2/2005	EMF

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST US PAT, USGPUB, EPO, JPO DERWENT, IBM	3/2/2005	EMF
PALM INVENTORSHIP	3/2/2005	EMF
ACM Digital Library Keyword Search	3/2/2005	EMF
IEEE Explore Keyword Search	3/2/2005	EMF
GOOGLE Keyword Search	3/2/2005	EMF